



**Accredited testing laboratory**

**DAR registration number: DAT-P-176/94-D1**

**Federal Motor Transport Authority (KBA)  
DAR registration number: KBA-P 00070-97**

**Appendix to test report 1-1079-01-02/09  
Calibration data, Phantom certificate  
and detail information of the DASY4 System**

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# 1 Calibration report "Probe ET3DV6"

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**S** Service suisse d'étalonnage  
**C** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Cetecom**

Certificate No: **ET3-1558\_Aug08**

| CALIBRATION CERTIFICATE  |  |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
|--|--|-----------------------------------|-------------------------|-------------------|------|----------------------------|-----------------------|--------------------|------------|--------------------------|--------|---------------------|------------|--------------------------|--------|---------------------|------------|--------------------------|--------|---------------------------|----------------|--------------------------|--------|----------------------------|-----------------|---------------------------|--------|----------------------------|-----------------|--------------------------|--------|------------------------|----------|-------------------------------|--------|------|---------|-------------------------------|--------|---------------------|------|-----------------------|-----------------|-----------------------|--------------|----------------------------------|------------------------|---------------------------|------------|-----------------------------------|------------------------|
| Object   | ET3DV6 - SN:1558   |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Calibration procedure(s)   | QA CAL-01.v6 and QA CAL-23.v3<br>Calibration procedure for dosimetric E-field probes |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Calibration date:  | August 15, 2008  |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Condition of the calibrated item   | In Tolerance   |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| <p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).<br/>The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity &lt; 70%.</p> <p>Calibration Equipment used (M&amp;TE critical for calibration)</p> <table border="1"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter E4419B</td> <td>GB41293874</td> <td>1-Apr-08 (No. 217-00788)</td> <td>Apr-09</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41495277</td> <td>1-Apr-08 (No. 217-00788)</td> <td>Apr-09</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41498087</td> <td>1-Apr-08 (No. 217-00788)</td> <td>Apr-09</td> </tr> <tr> <td>Reference 3 dB Attenuator</td> <td>SN: S5054 (3c)</td> <td>1-Jul-08 (No. 217-00865)</td> <td>Jul-09</td> </tr> <tr> <td>Reference 20 dB Attenuator</td> <td>SN: S5086 (20b)</td> <td>31-Mar-08 (No. 217-00787)</td> <td>Apr-09</td> </tr> <tr> <td>Reference 30 dB Attenuator</td> <td>SN: S5129 (30b)</td> <td>1-Jul-08 (No. 217-00866)</td> <td>Jul-09</td> </tr> <tr> <td>Reference Probe ES3DV2</td> <td>SN: 3013</td> <td>2-Jan-08 (No. ES3-3013_Jan08)</td> <td>Jan-09</td> </tr> <tr> <td>DAE4</td> <td>SN: 660</td> <td>3-Sep-07 (No. DAE4-660_Sep07)</td> <td>Sep-08</td> </tr> </tbody> </table><br><table border="1"> <thead> <tr> <th>Secondary Standards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>RF generator HP 8548C</td> <td>US3642UD1700</td> <td>4-Aug-09 (in house check Oct-07)</td> <td>In house check: Oct-09</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585</td> <td>18-Oct-01 (in house check Oct-07)</td> <td>In house check: Oct-08</td> </tr> </tbody> </table> |  |                                   |                         | Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration | Power meter E4419B | GB41293874 | 1-Apr-08 (No. 217-00788) | Apr-09 | Power sensor E4412A | MY41495277 | 1-Apr-08 (No. 217-00788) | Apr-09 | Power sensor E4412A | MY41498087 | 1-Apr-08 (No. 217-00788) | Apr-09 | Reference 3 dB Attenuator | SN: S5054 (3c) | 1-Jul-08 (No. 217-00865) | Jul-09 | Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-08 (No. 217-00787) | Apr-09 | Reference 30 dB Attenuator | SN: S5129 (30b) | 1-Jul-08 (No. 217-00866) | Jul-09 | Reference Probe ES3DV2 | SN: 3013 | 2-Jan-08 (No. ES3-3013_Jan08) | Jan-09 | DAE4 | SN: 660 | 3-Sep-07 (No. DAE4-660_Sep07) | Sep-08 | Secondary Standards | ID # | Check Date (in house) | Scheduled Check | RF generator HP 8548C | US3642UD1700 | 4-Aug-09 (in house check Oct-07) | In house check: Oct-09 | Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-07) | In house check: Oct-08 |
| Primary Standards  | ID #   | Cal Date (Certificate No.)        | Scheduled Calibration   |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Power meter E4419B   | GB41293874   | 1-Apr-08 (No. 217-00788)          | Apr-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Power sensor E4412A  | MY41495277   | 1-Apr-08 (No. 217-00788)          | Apr-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Power sensor E4412A  | MY41498087   | 1-Apr-08 (No. 217-00788)          | Apr-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Reference 3 dB Attenuator  | SN: S5054 (3c)   | 1-Jul-08 (No. 217-00865)          | Jul-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Reference 20 dB Attenuator   | SN: S5086 (20b)  | 31-Mar-08 (No. 217-00787)         | Apr-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Reference 30 dB Attenuator   | SN: S5129 (30b)  | 1-Jul-08 (No. 217-00866)          | Jul-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Reference Probe ES3DV2   | SN: 3013   | 2-Jan-08 (No. ES3-3013_Jan08)     | Jan-09                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| DAE4   | SN: 660  | 3-Sep-07 (No. DAE4-660_Sep07)     | Sep-08                  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Secondary Standards  | ID #   | Check Date (in house)             | Scheduled Check         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| RF generator HP 8548C  | US3642UD1700   | 4-Aug-09 (in house check Oct-07)  | In house check: Oct-09  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Network Analyzer HP 8753E  | US37390585   | 18-Oct-01 (in house check Oct-07) | In house check: Oct-08  |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Calibrated by:   | Name<br>Katja Pokovic  | Function<br>Technical Manager     | Signature<br>           |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| Approved by:   | Name<br>Niels Kuster   | Function<br>Quality Manager       | Signature<br>           |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
|  |  |                                   | Issued: August 15, 2008 |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |
| This calibration certificate shall not be reproduced except in full without written approval of the laboratory.  |  |                                   |                         |                   |      |                            |                       |                    |            |                          |        |                     |            |                          |        |                     |            |                          |        |                           |                |                          |        |                            |                 |                           |        |                            |                 |                          |        |                        |          |                               |        |      |         |                               |        |                     |      |                       |                 |                       |              |                                  |                        |                           |            |                                   |                        |

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Accreditation No.: **SCS 108**

**Glossary:**

TSL tissue simulating liquid  
 NORM<sub>x,y,z</sub> sensitivity in free space  
 ConvF sensitivity in TSL / NORM<sub>x,y,z</sub>  
 DCP diode compression point  
 Polarization  $\phi$   $\phi$  rotation around probe axis  
 Polarization  $\vartheta$   $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is normal to probe axis

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

**Methods Applied and Interpretation of Parameters:**

- *NORM<sub>x,y,z</sub>*: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). *NORM<sub>x,y,z</sub>* are only intermediate values, i.e., the uncertainties of *NORM<sub>x,y,z</sub>* does not effect the  $E^2$ -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP<sub>x,y,z</sub>*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM<sub>x,y,z</sub> \* ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1558

August 15, 2008

# Probe ET3DV6

## SN:1558

|                  |                    |
|------------------|--------------------|
| Manufactured:    | September 16, 2003 |
| Last calibrated: | August 23, 2007    |
| Recalibrated:    | August 15, 2008    |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

ET3DV6 SN:1558

August 15, 2008

**DASY - Parameters of Probe: ET3DV6 SN:1558**

|  |              |                       |                                |       |
|--|--------------|-----------------------|--------------------------------|-------|
| Sensitivity in Free Space <sup>A</sup> |              |                       | Diode Compression <sup>B</sup> |       |
| NormX                                  | 2.03 ± 10.1% | μV/(V/m) <sup>2</sup> | DCP X                          | 93 mV |
| NormY                                  | 1.83 ± 10.1% | μV/(V/m) <sup>2</sup> | DCP Y                          | 92 mV |
| NormZ                                  | 1.70 ± 10.1% | μV/(V/m) <sup>2</sup> | DCP Z                          | 95 mV |

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

|            |  |   |               |  |
|------------|--|---|---------------|--|
| <b>TSL</b> | <b>900 MHz</b>                                     | <b>Typical SAR gradient: 5 % per mm</b> |               |  |
|            | Sensor Center to Phantom Surface Distance          | <b>3.7 mm</b>                           | <b>4.7 mm</b> |  |
|            | SAR <sub>bs</sub> [%] Without Correction Algorithm | 10.5                                    | 6.4           |  |
|            | SAR <sub>bs</sub> [%] With Correction Algorithm    | 0.8                                     | 0.4           |  |

|            |  |  |               |  |
|------------|--|--|---------------|--|
| <b>TSL</b> | <b>1750 MHz</b>                                    | <b>Typical SAR gradient: 10 % per mm</b> |               |  |
|            | Sensor Center to Phantom Surface Distance          | <b>3.7 mm</b>                            | <b>4.7 mm</b> |  |
|            | SAR <sub>bs</sub> [%] Without Correction Algorithm | 10.1                                     | 6.1           |  |
|            | SAR <sub>bs</sub> [%] With Correction Algorithm    | 0.8                                      | 0.6           |  |

Sensor Offset

Probe Tip to Sensor Center **2.7 mm**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Page 8).

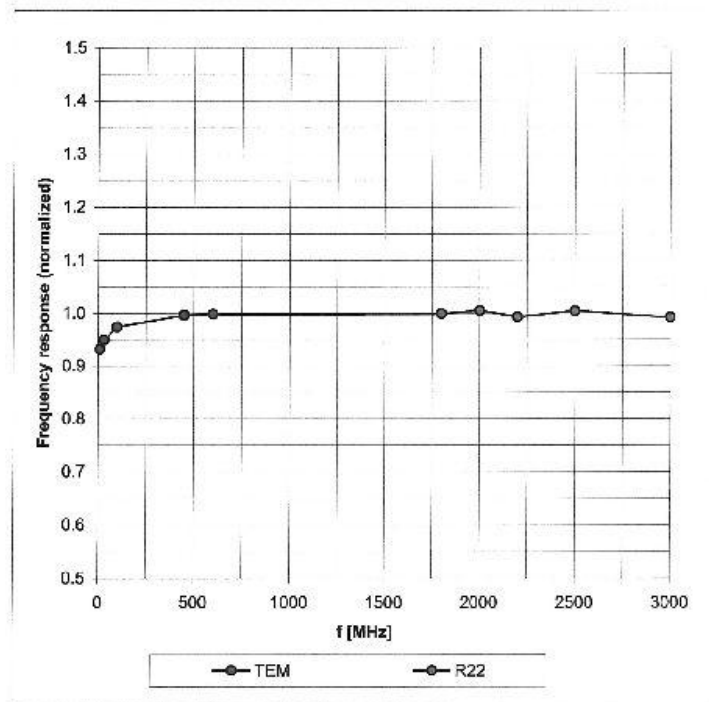
<sup>B</sup> Numerical linearization parameter: uncertainty not required.

ET3DV6 SN:1558

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### Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)

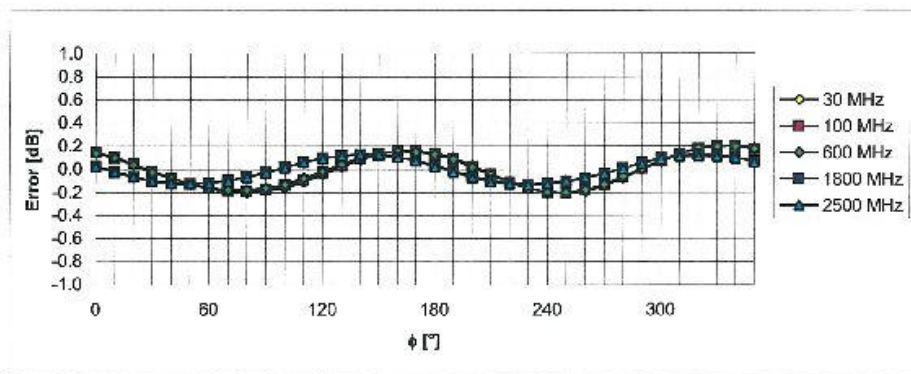
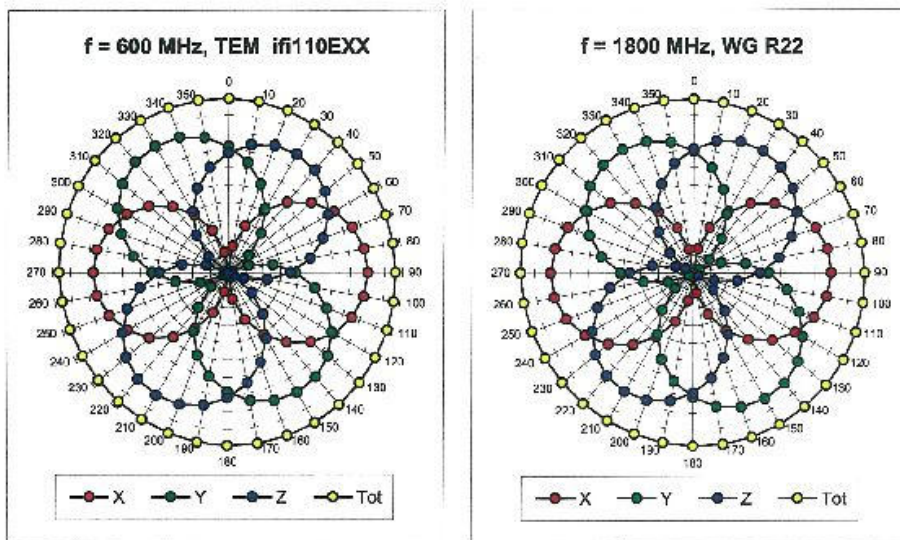


Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)

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Receiving Pattern ( $\phi$ ),  $\vartheta = 0^\circ$



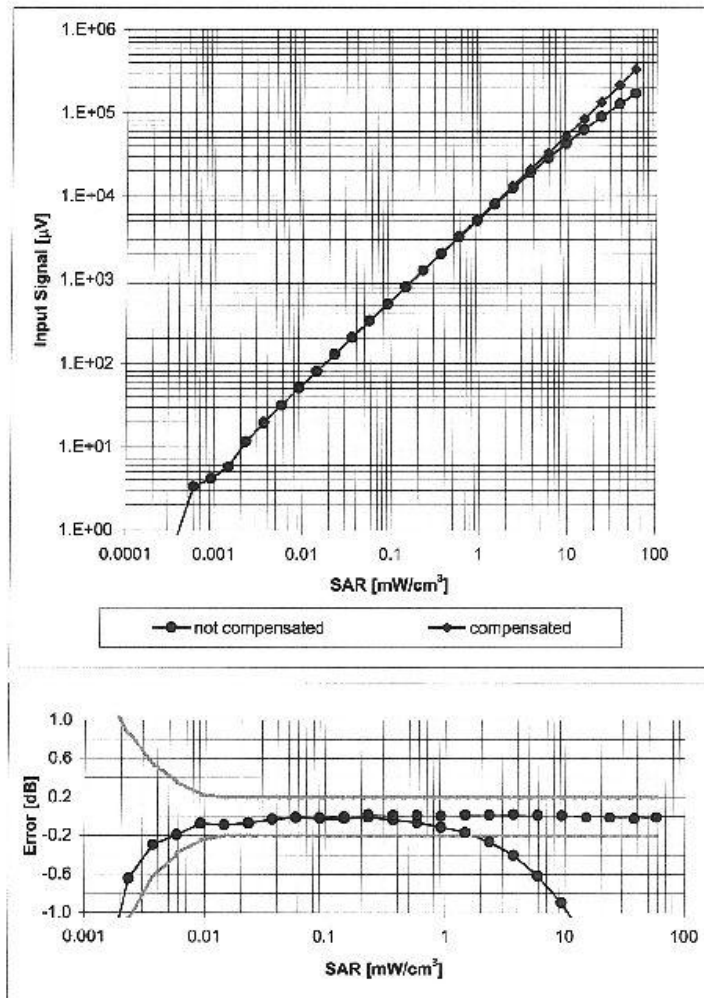
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



ET3DV6 SN:1558

August 15, 2008

**Dynamic Range  $f(SAR_{head})$**   
 (Waveguide R22,  $f = 1800$  MHz)

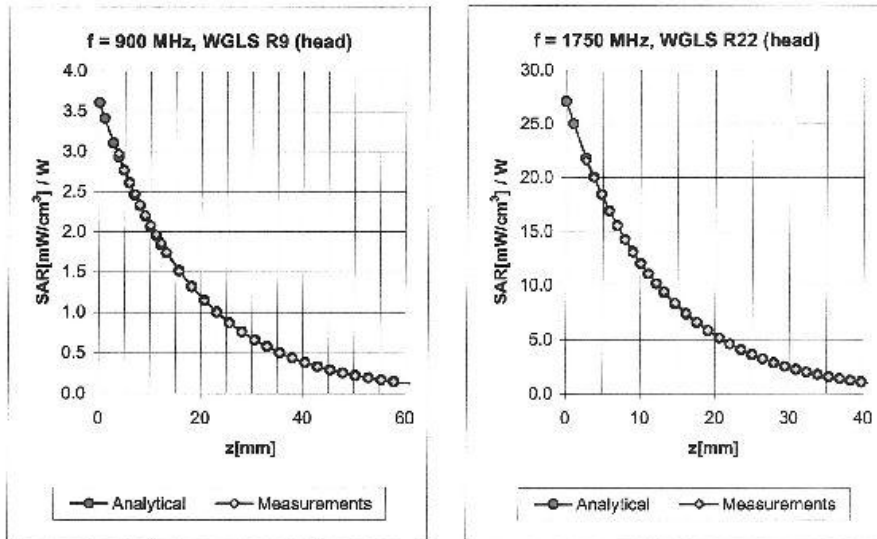


Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

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August 15, 2008

### Conversion Factor Assessment



| f [MHz] | Validity [MHz] <sup>c</sup> | TSL  | Permittivity | Conductivity | Alpha | Depth | ConvF Uncertainty  |
|---------|-----------------------------|------|--------------|--------------|-------|-------|--------------------|
| 835     | ± 50 / ± 100                | Head | 41.5 ± 5%    | 0.90 ± 5%    | 0.30  | 2.90  | 6.19 ± 11.0% (k=2) |
| 900     | ± 50 / ± 100                | Head | 41.5 ± 5%    | 0.97 ± 5%    | 0.30  | 2.90  | 5.99 ± 11.0% (k=2) |
| 1750    | ± 50 / ± 101                | Head | 40.1 ± 5%    | 1.37 ± 5%    | 0.65  | 1.98  | 5.19 ± 11.0% (k=2) |
| 1900    | ± 50 / ± 100                | Head | 40.0 ± 5%    | 1.40 ± 5%    | 0.69  | 1.84  | 4.96 ± 11.0% (k=2) |
| 2450    | ± 50 / ± 100                | Head | 39.2 ± 5%    | 1.80 ± 5%    | 0.90  | 1.45  | 4.40 ± 11.0% (k=2) |
| 835     | ± 50 / ± 100                | Body | 55.2 ± 5%    | 0.97 ± 5%    | 0.30  | 2.90  | 5.96 ± 11.0% (k=2) |
| 900     | ± 50 / ± 100                | Body | 55.0 ± 5%    | 1.05 ± 5%    | 0.32  | 2.95  | 5.80 ± 11.0% (k=2) |
| 1750    | ± 50 / ± 100                | Body | 53.4 ± 5%    | 1.49 ± 5%    | 0.65  | 2.03  | 4.62 ± 11.0% (k=2) |
| 1900    | ± 50 / ± 100                | Body | 53.3 ± 5%    | 1.52 ± 5%    | 0.71  | 1.88  | 4.39 ± 11.0% (k=2) |
| 2450    | ± 50 / ± 100                | Body | 52.7 ± 5%    | 1.95 ± 5%    | 0.92  | 1.45  | 3.86 ± 11.0% (k=2) |

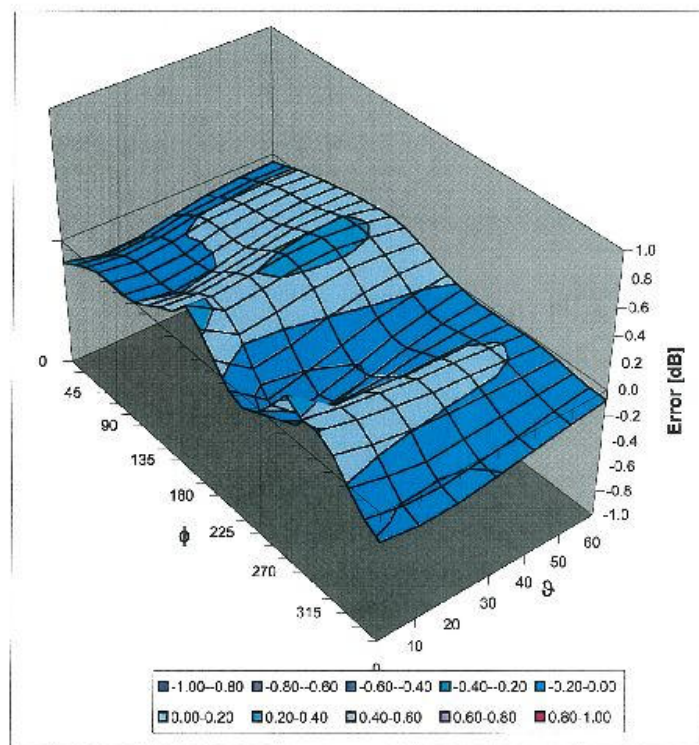
<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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### Deviation from Isotropy in HSL

Error ( $\phi$ ,  $\theta$ ),  $f = 900$  MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )

## 2 Calibration report "1900 MHz System validation dipole"

**Calibration Laboratory of  
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Accredited by the Swiss Federal Office of Metrology and Accreditation  
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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Cetecom**

Certificate No: **D1900V2-531\_May08**

### CALIBRATION CERTIFICATE

Object: **D1900V2 - SN: 531**

Calibration procedure(s): **QA CAL-05.v7  
Calibration procedure for dipole validation kits**

Calibration date: **May 14, 2008**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards           | ID #               | Cal Date (Calibrated by, Certificate No.) | Scheduled Calibration  |
|-----------------------------|--------------------|---|------------------------|
| Power meter EPM-442A        | GB37480704         | 04-Oct-07 (No. 217-00736)                 | Oct-08                 |
| Power sensor HP 8481A       | US37292783         | 04-Oct-07 (No. 217-00736)                 | Oct-08                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 07-Aug-07 (No. 217-00718)                 | Aug-08                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 08-Aug-07 (No. 217-00721)                 | Aug-08                 |
| Reference Probe ES3DV2      | SN: 3025           | 28-Apr-08 (No. ES3-3025_Apr08)            | Apr-09                 |
| DAE4                        | SN: 601            | 14-Mar-08 (No. DAE4-601_Mar08)            | Mar-09                 |
| Secondary Standards         | ID #               | Check Date (in house)                     | Scheduled Check        |
| Power sensor HP 8481A       | MY41092317         | 18-Oct-02 (in house check Oct-07)         | In house check: Oct-08 |
| RF generator R&S SMT-06     | 100005             | 4-Aug-99 (in house check Oct-07)          | In house check: Oct-09 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-07)         | In house check: Oct-08 |

|                |                       |                                   |               |
|----------------|-----------------------|-----------------------------------|---------------|
| Calibrated by: | Name<br>Marcel Fehr   | Function<br>Laboratory Technician | Signature<br> |
| Approved by:   | Name<br>Katja Pokovic | Function<br>Technical Manager     | Signature<br> |

Issued: May 14, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**S** Service suisse d'étalonnage  
**C** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

**Glossary:**

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

**Additional Documentation:**

- d) DASY4/5 System Handbook

**Methods Applied and Interpretation of Parameters:**

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

|                                     |                           |             |
|-------------------------------------|---------------------------|-------------|
| <b>DASY Version</b>                 | DASY4                     | V4.7        |
| <b>Extrapolation</b>                | Advanced Extrapolation    |             |
| <b>Phantom</b>                      | Modular Flat Phantom V5.0 |             |
| <b>Distance Dipole Center - TSL</b> | 10 mm                     | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm         |             |
| <b>Frequency</b>                    | 1900 MHz ± 1 MHz          |             |

**Head TSL parameters**

The following parameters and calculations were applied.

|   | Temperature     | Permittivity | Conductivity     |
|---|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>      | 22.0 °C         | 40.0         | 1.40 mho/m       |
| <b>Measured Head TSL parameters</b>     | (22.0 ± 0.2) °C | 39.4 ± 6 %   | 1.46 mho/m ± 8 % |
| <b>Head TSL temperature during test</b> | (21.0 ± 0.2) °C | ----         | ----             |

**SAR result with Head TSL**

| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | condition          |                                   |
|---|--------------------|-----------------------------------|
| SAR measured  | 250 mW input power | 9.67 mW / g                       |
| SAR normalized  | normalized to 1W   | 38.7 mW / g                       |
| SAR for nominal Head TSL parameters <sup>1</sup>            | normalized to 1W   | <b>37.6 mW / g ± 17.0 % (k=2)</b> |

| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | Condition          |                                   |
|---|--------------------|-----------------------------------|
| SAR measured  | 250 mW input power | 5.00 mW / g                       |
| SAR normalized  | normalized to 1W   | 20.0 mW / g                       |
| SAR for nominal Head TSL parameters <sup>1</sup>              | normalized to 1W   | <b>19.7 mW / g ± 16.5 % (k=2)</b> |

<sup>1</sup> Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

**Body TSL parameters**

The following parameters and calculations were applied.

|                                  | Temperature     | Permittivity | Conductivity     |
|----------------------------------|-----------------|--------------|------------------|
| Nominal Body TSL parameters      | 22.0 °C         | 53.3         | 1.52 mho/m       |
| Measured Body TSL parameters     | (22.0 ± 0.2) °C | 52.0 ± 6 %   | 1.54 mho/m ± 6 % |
| Body TSL temperature during test | (20.9 ± 0.2) °C | ---          | ---              |

**SAR result with Body TSL**

| SAR averaged over 1 cm <sup>3</sup> (1 g) of Body TSL | Condition          |                                   |
|---|--------------------|-----------------------------------|
| SAR measured  | 250 mW input power | 9.78 mW / g                       |
| SAR normalized  | normalized to 1W   | 39.1 mW / g                       |
| SAR for nominal Body TSL parameters <sup>2</sup>      | normalized to 1W   | <b>38.3 mW / g ± 17.0 % (k=2)</b> |

| SAR averaged over 10 cm <sup>3</sup> (10 g) of Body TSL | condition          |                                   |
|---|--------------------|-----------------------------------|
| SAR measured  | 250 mW input power | 5.13 mW / g                       |
| SAR normalized  | normalized to 1W   | 20.5 mW / g                       |
| SAR for nominal Body TSL parameters <sup>2</sup>        | normalized to 1W   | <b>20.2 mW / g ± 16.5 % (k=2)</b> |

<sup>2</sup> Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

**Appendix**

**Antenna Parameters with Head TSL**

|                                      |                                |
|--------------------------------------|--------------------------------|
| Impedance, transformed to feed point | 53.9 $\Omega$ + 4.7 j $\Omega$ |
| Return Loss                          | - 24.6 dB                      |

**Antenna Parameters with Body TSL**

|                                      |                                |
|--------------------------------------|--------------------------------|
| Impedance, transformed to feed point | 48.2 $\Omega$ + 5.3 j $\Omega$ |
| Return Loss                          | - 24.9 dB                      |

**General Antenna Parameters and Design**

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.201 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

**Additional EUT Data**

|                 |                  |
|-----------------|------------------|
| Manufactured by | SPEAG            |
| Manufactured on | January 24, 2001 |



**DASY4 Validation Report for Head TSL**

Date/Time: 08.05.2008 14:25:07

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:531**

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB;

Medium parameters used:  $f = 1900$  MHz;  $\sigma = 1.44$  mho/m;  $\epsilon_r = 39.4$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

**DASY4 Configuration:**

- Probe: ES3DV2 - SN3025; ConvF(4.9, 4.9, 4.9); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; ;
- Measurement SW: DASY4, V4.7 Build 55; Postprocessing SW: SEMCAD, V1.8 Build 172

**Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:**

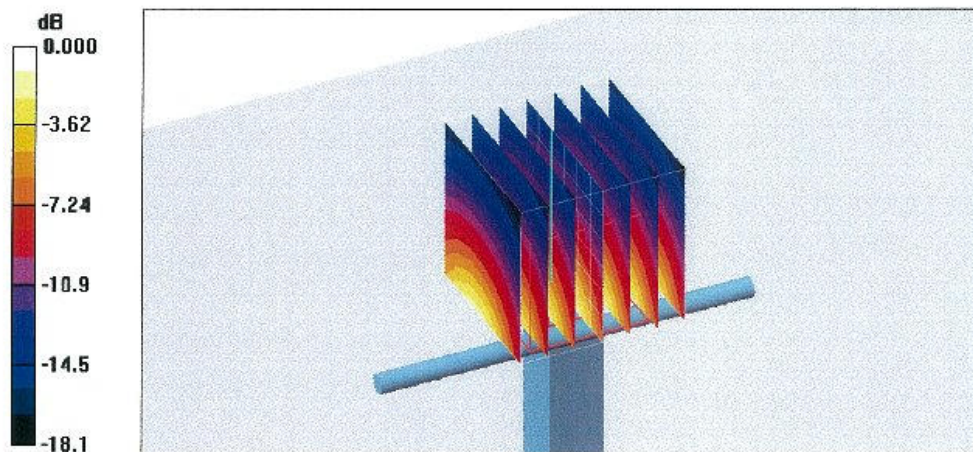
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 90.1 V/m; Power Drift = 0.030 dB

Peak SAR (extrapolated) = 17.9 W/kg

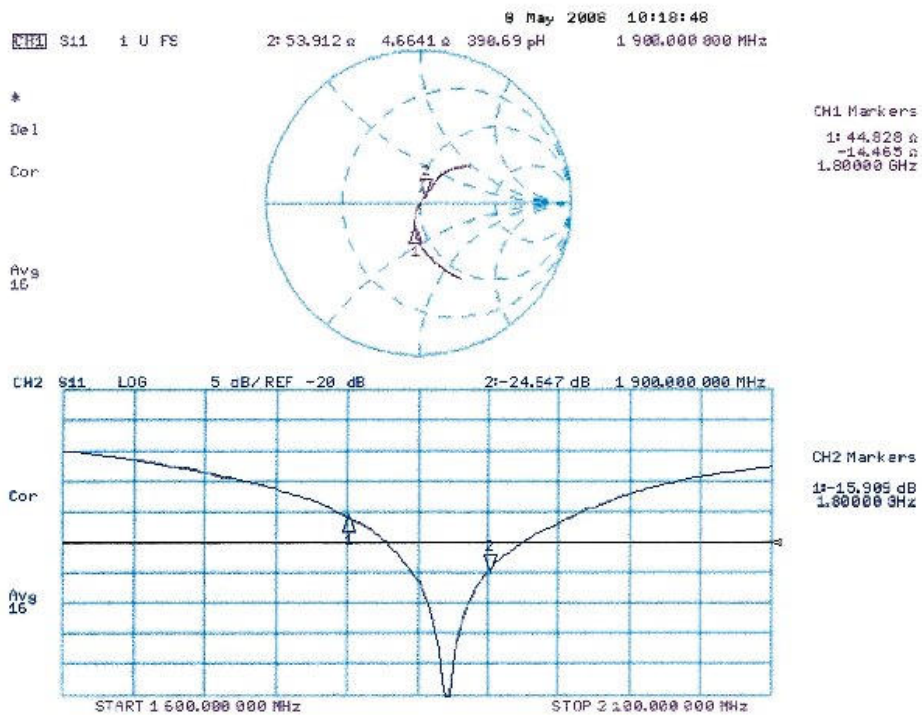
**SAR(1 g) = 9.67 mW/g; SAR(10 g) = 5 mW/g**

Maximum value of SAR (measured) = 11.4 mW/g



0 dB = 11.4mW/g

**Impedance Measurement Plot for Head TSL**



**DASY4 Validation Report for Body TSL**

Date/Time: 14.05.2008 16:36:27

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:531**

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB;

Medium parameters used:  $f = 1900$  MHz;  $\sigma = 1.54$  mho/m;  $\epsilon_r = 52.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.5, 4.5, 4.5); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; ;
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

**Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:**

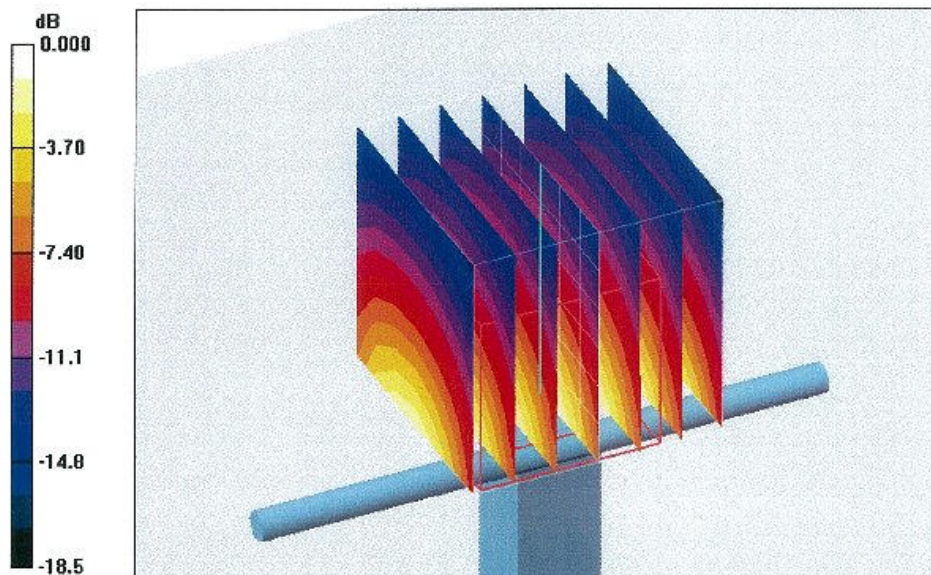
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 90.1 V/m; Power Drift = 0.011 dB

Peak SAR (extrapolated) = 17.4 W/kg

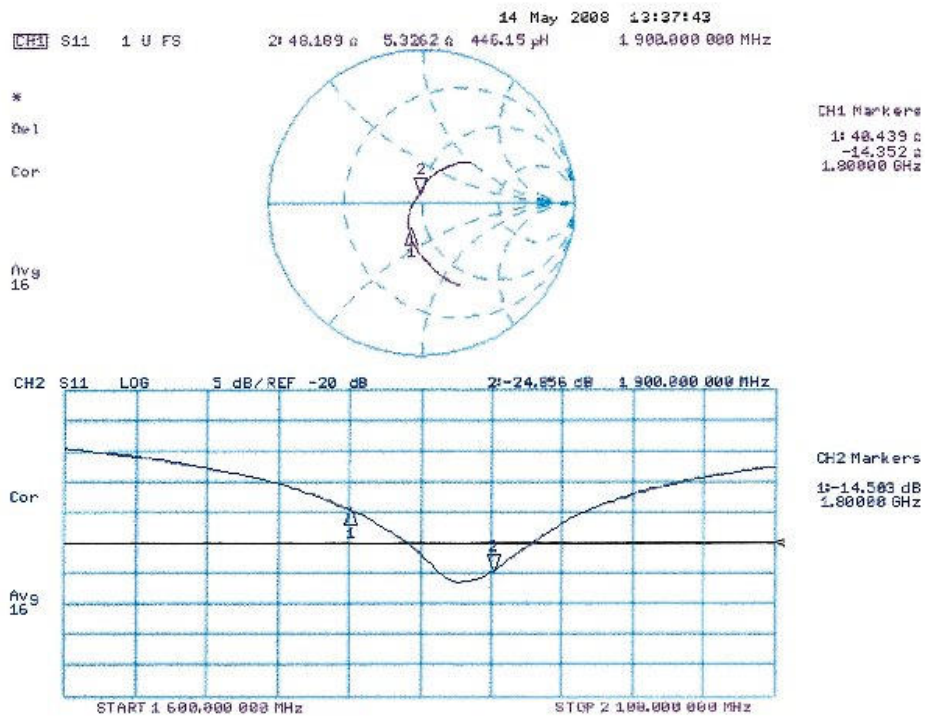
**SAR(1 g) = 9.78 mW/g; SAR(10 g) = 5.13 mW/g**

Maximum value of SAR (measured) = 11.8 mW/g



0 dB = 11.8mW/g

**Impedance Measurement Plot for Body TSL**



### 3 Calibration certificate of Data Aquisition Unit (DAE)

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**S** Service suisse d'étalonnage  
**C** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **CETECOM**

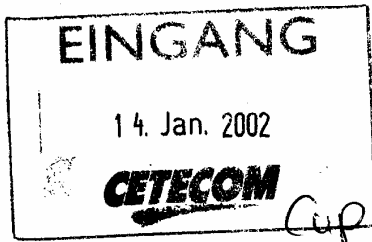
Certificate No: **DAE3-413\_Jan09**

| CALIBRATION CERTIFICATE   |   |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
|---|---|----------------------------|-------------------------|-------------------|------|----------------------------|-----------------------|------------------------------------|-------------|----------------------|--------|-------------------------------|-------------|----------------------|--------|---------------------|------|-----------------------|-----------------|---------------------|--------------------|----------------------------|------------------------|
| Object  | DAE3 - SD 000 D03 AA - SN: 413  |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Calibration procedure(s)  | QA CAL-06.v12<br>Calibration procedure for the data acquisition electronics (DAE) |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Calibration date:   | January 8, 2009   |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Condition of the calibrated item  | In Tolerance  |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| <p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).<br/>The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity &lt; 70%.</p> <p>Calibration Equipment used (M&amp;TE critical for calibration)</p> <table border="1"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Fliuke Process Calibrator Type 702</td> <td>SN: 6295803</td> <td>30-Sep-08 (No: 7673)</td> <td>Sep-09</td> </tr> <tr> <td>Keithley Multimeter Type 2001</td> <td>SN: 0810278</td> <td>30-Sep-08 (No: 7670)</td> <td>Sep-09</td> </tr> </tbody> </table><br><table border="1"> <thead> <tr> <th>Secondary Stancards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>Calibrator Box V1.1</td> <td>SE UMS 008 AB 1004</td> <td>06-Jun-08 (in house check)</td> <td>In house check: Jun-09</td> </tr> </tbody> </table> |   |                            |                         | Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration | Fliuke Process Calibrator Type 702 | SN: 6295803 | 30-Sep-08 (No: 7673) | Sep-09 | Keithley Multimeter Type 2001 | SN: 0810278 | 30-Sep-08 (No: 7670) | Sep-09 | Secondary Stancards | ID # | Check Date (in house) | Scheduled Check | Calibrator Box V1.1 | SE UMS 008 AB 1004 | 06-Jun-08 (in house check) | In house check: Jun-09 |
| Primary Standards   | ID #  | Cal Date (Certificate No.) | Scheduled Calibration   |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Fliuke Process Calibrator Type 702  | SN: 6295803   | 30-Sep-08 (No: 7673)       | Sep-09                  |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Keithley Multimeter Type 2001   | SN: 0810278   | 30-Sep-08 (No: 7670)       | Sep-09                  |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Secondary Stancards   | ID #  | Check Date (in house)      | Scheduled Check         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Calibrator Box V1.1   | SE UMS 008 AB 1004  | 06-Jun-08 (in house check) | In house check: Jun-09  |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Calibrated by:  | Name<br>Dominique Steffen   | Function<br>Technician     | Signature<br>           |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| Approved by:  | Fin Bernholt  | R&D Director               |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
|   |   |                            | Issued: January 8, 2009 |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |
| This calibration certificate shall not be reproduced except in full without written approval of the laboratory.   |   |                            |                         |                   |      |                            |                       |                                    |             |                      |        |                               |             |                      |        |                     |      |                       |                 |                     |                    |                            |                        |

## 4 Certificate of "SAM Twin Phantom V4.0/V4.0C"

### Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79



CETECOM ICT Services GmbH  
Bernd Rebmann  
Untertürkheimer Str. 6-10  
66117 Saarbrücken  
Deutschland

Zurich, January 10, 2002

#### Certificate of Conformity

Dear Bernd

It has been a while since you have received your SAM Twin Phantom V4.0/V4.0C.

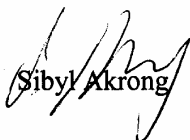
Several of our customers have required a document to justify to the authorities that the SAM phantom used for SAR measurements is conformant with the respective standards.

For your documentation please find enclosed a copy of the duly signed "Certificate of Conformity/First Article Inspection" (Document No. 881 - QD 000 P40 BA - B). With this certificate we confirm conformity with the CENELEC EN 50361, IEEE P1528-200x draft 6.5 and the IEC PT 62209 draft 0.9 standards.

Please do not hesitate to contact us in case you have any questions or are in need of further clarification. You can always reach us at +41-1-245 97 00 or by e-mail to [info@speag.com](mailto:info@speag.com).

Best regards,

Schmid & Partner Engineering AG



Sibyl Akrong

## Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

### Certificate of conformity / First Article Inspection

|                       |  |
|-----------------------|--|
| Item                  | SAM Twin Phantom V4.0  |
| Type No               | QD 000 P40 BA  |
| Series No             | TP-1002 and higher   |
| Manufacturer / Origin | Untersee Composites<br>Hauptstr. 69<br>CH-8559 Fruthwilen<br>Switzerland |

#### Tests

The series production process used allows the limitation to test of first articles. Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series units (called samples).

| Test                 | Requirement   | Details  | Units tested              |
|----------------------|---|--|---------------------------|
| Shape                | Compliance with the geometry according to the CAD model.                                | IT'IS CAD File (*)   | First article, Samples    |
| Material thickness   | Compliant with the requirements according to the standards                              | 2mm +/- 0.2mm in specific areas                                      | First article, Samples    |
| Material parameters  | Dielectric parameters for required frequencies  | 200 MHz – 3 GHz<br>Relative permittivity < 5<br>Loss tangent < 0.05. | Material sample TP 104-5  |
| Material resistivity | The material has been tested to be compatible with the liquids defined in the standards | Liquid type HSL 1800 and others according to the standard.           | Pre-series, First article |

#### Standards

- [1] CENELEC EN 50361
- [2] IEEE P1529-200x draft 6.5
- [3] IEC PT 62209 draft 0.9
- (\*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of [1] and [3].

#### Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standard [1] and draft standards [2] and [3].

Date 18.11.2001

Signature / Stamp  Schmid & Partner Engineering AG 

Zeughausstrasse 43, CH-8004 Zurich  
Tel. +41 1 245 97 00, Fax +41 1 245 97 79

## 5 Application Note System Performance Check

### 5.1.1.1 Purpose of system performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check is performed prior to any usage of the system in order to guarantee reproducible results.

The measurement of the Specific Absorption Rate (SAR) is a complicated task and the result depends on the proper functioning of many components and the correct settings of many parameters. Faulty results due to drift, failures or incorrect parameters might not be recognized, since they often look similar in distribution to the correct ones. The Dosimetric Assessment System DASY4 incorporates a system performance check procedure to test the proper functioning of the system. The system performance check uses normal SAR measurements in a simplified setup (the at section of the SAM Twin Phantom) with a well characterized source (a matched dipole at a specified distance). This setup was selected to give a high sensitivity to all parameters that might fail or vary over time (e.g., probe, liquid parameters, and software settings) and a low sensitivity to external effects inherent in the system (e.g., positioning uncertainty of the device holder). The system performance check does not replace the calibration of the components. The accuracy of the system performance check is not sufficient for calibration purposes. It is possible to calculate the field quite accurately in this simple setup; however, due to the open field situation some factors (e.g., laboratory reflections) cannot be accounted for. Calibrations in the at phantom are possible with transfer calibration methods, using either temperature probes or calibrated E-field probes. The system performance check also does not test the system performance for arbitrary field situations encountered during real measurements of mobile phones. These checks are performed at SPEAG by testing the components under various conditions (e.g., spherical isotropy measurements in liquid, linearity measurements, temperature variations, etc.), the results of which are used for an error estimation of the system. The system performance check will indicate situations where the system uncertainty is exceeded due to drift or failure.

### 5.1.1.2 System Performance check procedure

#### Preparation

The conductivity should be measured before the validation and the measured liquid parameters must be entered in the software. If the measured values differ from targeted values in the dipole document, the liquid composition should be adjusted. If the validation is performed with slightly different (measured) liquid parameters, the expected SAR will also be different. See the application note about SAR sensitivities for an estimate of possible SAR deviations. Note that the liquid parameters are temperature dependent with approximately – 0.5% decrease in permittivity and + 1% increase in conductivity for a temperature decrease of 1° C. The dipole must be placed beneath the flat phantom section of the Generic Twin Phantom with the correct distance holder in place. The distance holder should touch the phantom surface with a light pressure at the reference marking (little hole) and be oriented parallel to the long side of the phantom. Accurate positioning is not necessary, since the system will search for the peak SAR location, except that the dipole arms should be parallel to the surface. The device holder for mobile phones can be left in place but should be rotated away from the dipole. The forward power into the dipole at the dipole SMA connector should be determined as accurately as possible. See section 4 for a description of the recommended setup to measure the dipole input power. The actual dipole input power level can be between 20mW and several watts. The result can later be normalized to any power level. It is strongly recommended to note the actually used power level in the „comment“-window of the measurement file; otherwise you lose this crucial information for later reference.

#### System Performance Check

The DASY4 installation includes predefined files with recommended procedures for measurements and validation. They are read-only document files and destined as fully defined but unmeasured masks, so you must save the finished validation under a different name. The validation document requires the Generic Twin Phantom, so this phantom must be properly installed in your system. (You can create your own measurement procedures by opening a new document or editing an existing document file). Before you start the validation, you just have to tell the system with which components (probe, medium, and device) you are performing the validation; the system will take care of all parameters. After the validation, which will take about 20 minutes, the results of each task are



displayed in the document window. Selecting all measured tasks and opening the predefined “validation” graphic format displays all necessary information for validation. A description of the different measurement tasks in the predefined document is given below, together with the information that can be deduced from their results:

- The „reference“ and „drift“ measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure. The indicated drift is mainly the variation of the amplifier output power. If it is too high (above  $\pm 0.1$  dB) the validation should be repeated; some amplifiers have very high drift during warm-up. A stable amplifier gives drift results in the DASY4 system below  $\pm 0.02$  dB.
- The „surface check“ measurement tests the optical surface detection system of the DASY4 system by repeatedly detecting the surface with the optical and mechanical surface detector and comparing the results. The output gives the detecting heights of both systems, the difference between the two systems and the standard deviation of the detection repeatability. Air bubbles or refraction in the liquid due to separation of the sugar-water mixture gives poor repeatability (above  $\pm 0.1$  mm). In that case it is better to abort the validation and stir the liquid. The difference between the optical surface detection and the actual surface depends on the probe and is specified with each probe. (It does not depend on the surface reflectivity or the probe angle to the surface within  $\pm 30^\circ$ .) However, varying breaking indices of different liquid compositions might also influence the distance. If the indicated difference varies from the actual setting, the probe parameter „optical surface distance“ should be changed in the probe settings (see manual). For more information see the application note about SAR evaluation.
- The „area scan“ measures the SAR above the dipole on a parallel plane to the surface. It is used to locate the approximate location of the peak SAR with 2D spline interpolation. The proposed scan uses large grid spacing for faster measurement; due to the symmetric field the peak detection is reliable. If a finer graphic is desired, the grid spacing can be reduced. Grid spacing and orientation have no influence on the SAR result.
- The zoom scan job measures the field in a volume around the peak SAR value assessed in the previous „area“ scan (for more information see the application note on SAR evaluation).

If the validation measurements give reasonable results, the peak 1g and 10g spatial SAR values averaged between the two cubes and normalized to 1W dipole input power give the reference data for comparisons. The next section analyzes the expected uncertainties of these values. Section 6 describes some additional checks for further information or troubleshooting.

### 5.1.1.3 Uncertainty Budget

Please note that in the following Tables, the tolerance of the following uncertainty components depends on the actual equipment and setup at the user location and need to be either assessed or verified on-site by the end user of the DASY4 system:

- RF ambient conditions
- Dipole Axis to Liquid Distance
- Input power and SAR drift measurement
- Liquid permittivity - measurement uncertainty
- Liquid conductivity - measurement uncertainty

Note: All errors are given in percent of SAR, so 0.1 dB corresponds to 2.3%. The field error would be half of that. the liquid parameter assessment give the targeted values from the dipole document. All errors are given in percent of SAR, so 0.1dB corresponds to 2.3%. The field error would be half of that.

**System validation**

In the table below, the system validation uncertainty with respect to the analytically assessed SAR value of a dipole source as given in the P1528 standard is given. This uncertainty is smaller than the expected uncertainty for mobile phone measurements due to the simplified setup and the symmetric field distribution.

| Error Sources                    | Uncertainty Value | Probability Distribution | Divisor | c <sub>i</sub> 1g | c <sub>i</sub> 10g | Standard Uncertainty | Standard Uncertainty | v <sub>i</sub> <sup>2</sup> or v <sub>eff</sub> |
|----------------------------------|-------------------|--------------------------|---------|-------------------|--------------------|----------------------|----------------------|---|
| <b>Measurement System</b>        |                   |                          |         |                   |                    |                      |                      |   |
| Probe calibration                | ± 4.8%            | Normal                   | 1       | 1                 | 1                  | ± 4.8%               | ± 4.8%               | ∞   |
| Axial isotropy                   | ± 4.7%            | Rectangular              | √3      | 0.7               | 0.7                | ± 1.9%               | ± 1.9%               | ∞   |
| Hemispherical isotropy           | ± 0.0%            | Rectangular              | √3      | 0.7               | 0.7                | ± 0.0%               | ± 0.0%               | ∞   |
| Boundary effects                 | ± 1.0%            | Rectangular              | √3      | 1                 | 1                  | ± 0.6%               | ± 0.6%               | ∞   |
| Probe linearity                  | ± 4.7%            | Rectangular              | √3      | 1                 | 1                  | ± 2.7%               | ± 2.7%               | ∞   |
| System detection limits          | ± 1.0%            | Rectangular              | √3      | 1                 | 1                  | ± 0.6%               | ± 0.6%               | ∞   |
| Readout electronics              | ± 1.0%            | Normal                   | 1       | 1                 | 1                  | ± 1.0%               | ± 1.0%               | ∞   |
| Response time                    | ± 0.0%            | Rectangular              | √3      | 1                 | 1                  | ± 0.0%               | ± 0.0%               | ∞   |
| Integration time                 | ± 0.0%            | Rectangular              | √3      | 1                 | 1                  | ± 0.0%               | ± 0.0%               | ∞   |
| RF ambient conditions            | ± 3.0%            | Rectangular              | √3      | 1                 | 1                  | ± 1.7%               | ± 1.7%               | ∞   |
| Probe positioner                 | ± 0.4%            | Rectangular              | √3      | 1                 | 1                  | ± 0.2%               | ± 0.2%               | ∞   |
| Probe positioning                | ± 2.9%            | Rectangular              | √3      | 1                 | 1                  | ± 1.7%               | ± 1.7%               | ∞   |
| Max. SAR evaluation              | ± 1.0%            | Rectangular              | √3      | 1                 | 1                  | ± 0.6%               | ± 0.6%               | ∞   |
| <b>Dipole</b>                    |                   |                          |         |                   |                    |                      |                      |   |
| Dipole axis to liquid distance   | ± 2.0%            | Normal                   | 1       | 1                 | 1                  | ± 1.2%               | ± 1.2%               | ∞   |
| Input power and power drift      | ± 4.7%            | Rectangular              | √3      | 1                 | 1                  | ± 2.7%               | ± 2.7%               | ∞   |
| <b>Phantom and Set-up</b>        |                   |                          |         |                   |                    |                      |                      |   |
| Phantom uncertainty              | ± 4.0%            | Rectangular              | √3      | 1                 | 1                  | ± 2.3%               | ± 2.3%               | ∞   |
| Liquid conductivity (target)     | ± 5.0%            | Rectangular              | √3      | 0.64              | 0.43               | ± 1.8%               | ± 1.2%               | ∞   |
| Liquid conductivity (meas.)      | ± 2.5%            | Rectangular              | 1       | 0.64              | 0.43               | ± 1.6%               | ± 1.1%               | ∞   |
| Liquid permittivity (target)     | ± 5.0%            | Rectangular              | √3      | 0.6               | 0.49               | ± 1.7%               | ± 1.4%               | ∞   |
| Liquid permittivity (meas.)      | ± 2.5%            | Rectangular              | 1       | 0.6               | 0.49               | ± 1.5%               | ± 1.2%               | ∞   |
| <b>Combined Uncertainty</b>      |                   |                          |         |                   |                    | <b>± 8.4%</b>        | <b>± 8.1%</b>        | ∞   |
| <b>Expanded Std. Uncertainty</b> |                   |                          |         |                   |                    | <b>± 16.8%</b>       | <b>± 1.2%</b>        |   |

**Performance check repeatability**

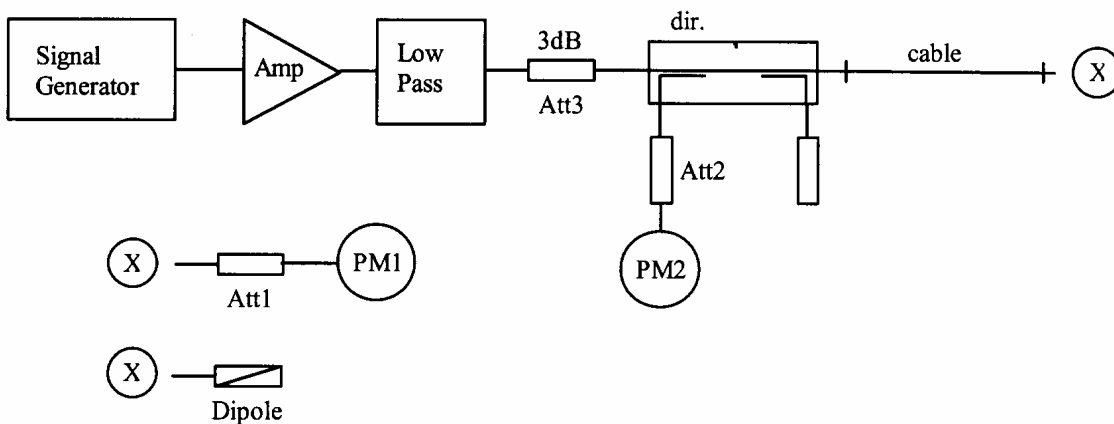
The repeatability check of the validation is insensitive to external effects and gives an indication of the variations in the DASY4 measurement system, provided that the same power reading setup is used for all validations. The repeatability estimate is given in the following table:

| Error Sources                    | Uncertainty Value | Probability Distribution | Divisor | c <sub>i</sub><br>1g | c <sub>i</sub><br>10g | Standard Uncertainty | Standard Uncertainty | v <sub>i</sub> <sup>2</sup> or v <sub>eff</sub> |
|----------------------------------|-------------------|--------------------------|---------|----------------------|-----------------------|----------------------|----------------------|---|
| <b>Measurement System</b>        |                   |                          |         |                      |                       |                      |                      |   |
| Probe calibration                | ± 4.8%            | Normal                   | 1       | 1                    | 1                     | 0                    | 0                    | ∞   |
| Axial isotropy                   | ± 4.7%            | Rectangular              | √3      | 0.7                  | 0.7                   | 0                    | 0                    | ∞   |
| Hemispherical isotropy           | ± 0.0%            | Rectangular              | √3      | 0.7                  | 0.7                   | 0                    | 0                    | ∞   |
| Boundary effects                 | ± 1.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Probe linearity                  | ± 4.7%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| System detection limits          | ± 1.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Readout electronics              | ± 1.0%            | Normal                   | 1       | 1                    | 1                     | 0                    | 0                    | ∞   |
| Response time                    | ± 0.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Integration time                 | ± 0.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| RF ambient conditions            | ± 3.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Probe positioner                 | ± 0.4%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Probe positioning                | ± 2.9%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| Max. SAR evaluation              | ± 1.0%            | Rectangular              | √3      | 1                    | 1                     | 0                    | 0                    | ∞   |
| <b>Dipole</b>                    |                   |                          |         |                      |                       |                      |                      |   |
| Dipole axis to liquid distance   | ± 2.0%            | Normal                   | 1       | 1                    | 1                     | ± 1.2%               | ± 1.2%               | ∞   |
| Input power and power drift      | ± 4.7%            | Rectangular              | √3      | 1                    | 1                     | ± 2.7%               | ± 2.7%               | ∞   |
| <b>Phantom and Set-up</b>        |                   |                          |         |                      |                       |                      |                      |   |
| Phantom uncertainty              | ± 4.0%            | Rectangular              | √3      | 1                    | 1                     | ± 2.3%               | ± 2.3%               | ∞   |
| Liquid conductivity (target)     | ± 5.0%            | Rectangular              | √3      | 0.64                 | 0.43                  | ± 1.8%               | ± 1.2%               | ∞   |
| Liquid conductivity (meas.)      | ± 2.5%            | Rectangular              | 1       | 0.64                 | 0.43                  | ± 1.6%               | ± 1.1%               | ∞   |
| Liquid permittivity (target)     | ± 5.0%            | Rectangular              | √3      | 0.6                  | 0.49                  | ± 1.7%               | ± 1.4%               | ∞   |
| Liquid permittivity (meas.)      | ± 2.5%            | Rectangular              | 1       | 0.6                  | 0.49                  | ± 1.5%               | ± 1.2%               | ∞   |
| <b>Combined Uncertainty</b>      |                   |                          |         |                      |                       | <b>± 5.3%</b>        | <b>± 4.9%</b>        | ∞   |
| <b>Expanded Std. Uncertainty</b> |                   |                          |         |                      |                       | <b>± 10.6%</b>       | <b>± 9.7%</b>        |   |

The expected repeatability deviation is low. Excessive drift (e.g., drift in liquid parameters), partial system failures or incorrect parameter settings (e.g., wrong probe or device settings) will lead to unexpectedly high repeatability deviations. The repeatability gives an indication that the system operates within its initial specifications. Excessive drift, system failure and operator errors are easily detected.

**5.1.1.4 Power set-up for validation**

The uncertainty of the dipole input power is a significant contribution to the absolute uncertainty and the expected deviation in interlaboratory comparisons. The values in Section 2 for a typical and a sophisticated setup are just average values. Refer to the manual of the power meter and the detector head for the evaluation of the uncertainty in your system. The uncertainty also depends on the source matching and the general setup. Below follows the description of a recommended setup and procedures to increase the accuracy of the power reading:



The figure shows the recommended setup. The PM1 (incl. Att1) measures the forward power at the location of the validation dipole connector. The signal generator is adjusted for the desired forward power at the dipole connector and the power meter PM2 is read at that level. After connecting the cable to the dipole, the signal generator is readjusted for the same reading at power meter PM2. If the signal generator does not allow a setting in 0.01dB steps, the remaining difference at PM2 must be noted and considered in the normalization of the validation results. The requirements for the components are:

- The signal generator and amplifier should be stable (after warm-up). The forward power to the dipole should be above 10mW to avoid the influence of measurement noise. If the signal generator can deliver 15dBm or more, an amplifier is not necessary. Some high power amplifiers should not be operated at a level far below their maximum output power level (e.g. a 100W power amplifier operated at 250mW output can be quite noisy). An attenuator between the signal generator and amplifier is recommended to protect the amplifier input.
- The low pass filter after the amplifier reduces the effect of harmonics and noise from the amplifier. For most amplifiers in normal operation the filter is not necessary.
- The attenuator after the amplifier improves the source matching and the accuracy of the power head. (See power meter manual.) It can also be used also to make the amplifier operate at its optimal output level for noise and stability. In a setup without directional coupler, this attenuator should be at least 10dB.
- The directional coupler (recommended <sup>3</sup> 20dB) is used to monitor the forward power and adjust the signal generator output for constant forward power. A medium quality coupler is sufficient because the loads (dipole and power head) are well matched. (If the setup is used for reflective loads, a high quality coupler with respect to directivity and output matching is necessary to avoid additional errors.)
- The power meter PM2 should have a low drift and a resolution of 0.01dBm, but otherwise its accuracy has no impact on the power setting. Calibration is not required.
- The cable between the coupler and dipole must be of high quality, without large attenuation and phase changes when it is moved. Otherwise, the power meter head PM1 should be brought to the location of the dipole for measuring.
- The power meter PM1 and attenuator Att1 must be high quality components. They should be calibrated, preferably together. The attenuator (<sup>3</sup>10dB) improves the accuracy of the power reading. (Some higher power

heads come with a built-in calibrated attenuator.) The exact attenuation of the attenuator at the frequency used must be known; many attenuators are up to 0.2dB off from the specified value.

- Use the same power level for the power setup with power meter PM1 as for the actual measurement to avoid linearity and range switching errors in the power meter PM2. If the validation is performed at various power levels, do the power setting procedure at each level.
- The dipole must be connected directly to the cable at location “X”. If the power meter has a different connector system, use high quality couplers. Preferably, use the couplers at the attenuator Att1 and calibrate the attenuator with the coupler.
- Always remember: We are measuring power, so 1% is equivalent to 0.04dB.

#### 5.1.1.5 Laboratory reflections

In near-field situations, the absorption is predominantly caused by induction effects from the magnetic near-field. The absorption from reflected fields in the laboratory is negligible. On the other hand, the magnetic field around the dipole depends on the currents and therefore on the feedpoint impedance. The feedpoint impedance of the dipole is mainly determined from the proximity of the absorbing phantom, but reflections in the laboratory can change the impedance slightly. A 1% increase in the real part of the feedpoint impedance will produce approximately a 1% decrease in the SAR for the same forward power. The possible influence of laboratory reflections should be investigated during installation. The validation setup is suitable for this check, since the validation is sensitive to laboratory reflections. The same tests can be performed with a mobile phone, but most phones are less sensitive to reflections due to the shorter distance to the phantom. The fastest way to check for reflection effects is to position the probe in the phantom above the feedpoint and start a continuous field measurement in the DASY4 multimeter window. Placing absorbers in front of possible reflectors (e.g. on the ground near the dipole or in front of a metallic robot socket) will reveal their influence immediately. A 10dB absorber (e.g. ferrite tiles or flat absorber mats) is probably sufficient, as the influence of the reflections is small anyway. If you place the absorber too near the dipole, the absorber itself will interact with the reactive near-field. Instead of measuring the SAR, it is also possible to monitor the dipole impedance with a network analyzer for reflection effects. The network analyzer must be calibrated at the SMA connector and the electrical delay (two times the forward delay in the dipole document) must be set in the NWA for comparisons with the reflection data in the dipole document. If the absorber has a significant influence on the results, the absorber should be left in place for validation or measurements. The reference data in the dipole document are produced in a low reflection environment.

#### 5.1.1.6 Additional system checks

While the validation gives a good check of the DASY4 system components, it does not include all parameters necessary for real phone measurements (e.g. device modulation or device positioning). For system validation (repeatability) or comparisons between laboratories a reference device can be useful. This can be any mobile phone with a stable output power (preferably a device whose output power can be set through the keyboard). For comparisons, the same device should be sent around, since the SAR variations between samples can be large. Several measurement possibilities in the DASY software allow additional tests of the performance of the DASY system and components. These tests can be useful to localize component failures:

- The validation can be performed at different power levels to check the noise level or the correct compensation of the diode compression in the probe.
- If a pulsed signal with high peak power levels is fed to the dipole, the performance of the diode compression compensation can be tested. The correct crest factor parameter in the DASY software must be set (see manual). The system should give the same SAR output for the same averaged input power.
- The probe isotropy can be checked with a 1D-probe rotation scan above the feedpoint. The automatic probe alignment procedure must be passed through for accurate probe rotation movements (optional DASY4 feature with a robot-mounted light beam unit). Otherwise the probe tip might move on a small circle during rotation, producing some additional isotropy errors in gradient fields.